

**N-Channel Enhancement-Mode  
Vertical DMOS FETs****Ordering Information**

$BV_{DSS}$ / $BV_{DGS}$	$R_{DS(ON)}$ (max)	$V_{GS(th)}$ (max)	Order Number / Package
300V	25Ω	2.4V	TO-236AB* TN2130K1

Product marking for SOT-23:  
N1T\*  
where \* = 2-week alpha date code

\*Same as SOT-23. All units shipped on 3,000 piece carrier tape reels.

**Features**

- Free from secondary breakdown
- Low power drive requirement
- Ease of paralleling
- Low  $C_{iss}$  and fast switching speeds
- Excellent thermal stability
- Integral Source-Drain diode
- High input impedance and high gain

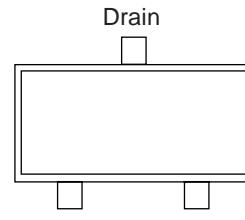
**Advanced DMOS Technology**

These enhancement-mode (normally-off) transistors utilize a vertical DMOS structure and Supertex's well-proven silicon-gate manufacturing process. This combination produces devices with the power handling capabilities of bipolar transistors and with the high input impedance and positive temperature coefficient inherent in MOS devices. Characteristic of all MOS structures, these devices are free from thermal runaway and thermally-induced secondary breakdown.

Supertex's vertical DMOS FETs are ideally suited to a wide range of switching and amplifying applications where high breakdown voltage, high input impedance, low input capacitance, and fast switching speeds are desired.

**Applications**

- Logic level interfaces – ideal for TTL and CMOS
- Solid state relays
- Battery operated systems
- Photo voltaic drives
- Analog switches
- General purpose line drivers
- Telecom switches

**Package Options**

TO-236AB

(SOT-23)

top view

Note: See Package Outline section for dimensions.

**Absolute Maximum Ratings**

Drain-to-Source Voltage	$BV_{DSS}$
Drain-to-Gate Voltage	$BV_{DGS}$
Gate-to-Source Voltage	$\pm 20V$
Operating and Storage Temperature	-55°C to +150°C
Soldering Temperature*	300°C

\* Distance of 1.6 mm from case for 10 seconds.

## Thermal Characteristics

Package	$I_D$ (continuous)*	$I_D$ (pulsed)	Power Dissipation @ $T_A = 25^\circ\text{C}$	$\theta_{jc}$ °C/W	$\theta_{ja}$ °C/W	$I_{DR}^*$	$I_{DRM}$
TO-236AB	85mA	200mA	0.36W	200	350	85mA	200mA

\*  $I_D$  (continuous) is limited by max rated  $T_j$ .

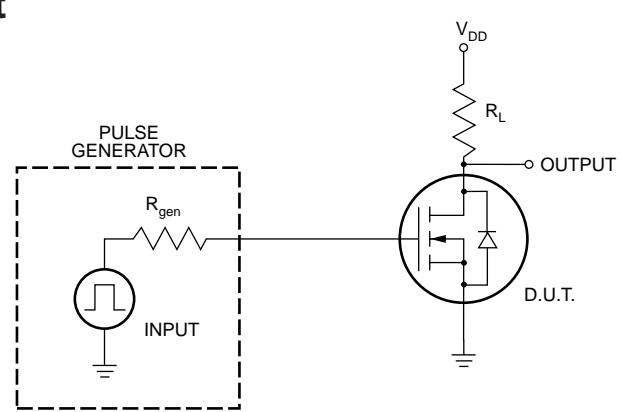
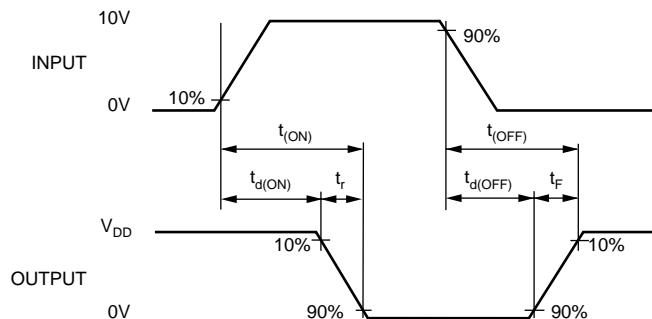
## Electrical Characteristics (@ 25°C unless otherwise specified)

Symbol	Parameter	Min	Typ	Max	Unit	Conditions
$BV_{DSS}$	Drain-to-Source Breakdown Voltage	300			V	$I_D = 1\text{mA}$ , $V_{GS} = 0\text{V}$
$V_{GS(th)}$	Gate Threshold Voltage	0.8		2.4	V	$V_{GS} = V_{DS}$ , $I_D = 1\text{mA}$
$\Delta V_{GS(th)}$	Change in $V_{GS(th)}$ with Temperature			-5.5	mV/°C	$I_D = 1\text{mA}$ , $V_{GS} = V_{DS}$
$I_{GSS}$	Gate Body Leakage			100	nA	$V_{GS} = \pm 20\text{V}$ , $V_{DS} = 0\text{V}$
$I_{DSS}$	Zero Gate Voltage Drain Current			10	$\mu\text{A}$	$V_{GS} = 0\text{V}$ , $V_{DS} = \text{Max Rating}$
				100	$\mu\text{A}$	$V_{GS} = 0\text{V}$ , $V_{DS} = 0.8$ Max Rating $T_A = 125^\circ\text{C}$
$I_{D(ON)}$	ON-State Drain Current	250			mA	$V_{GS} = 10\text{V}$ , $V_{DS} = 25\text{V}$
$R_{DS(ON)}$	Static Drain-to-Source ON-State Resistance			25	$\Omega$	$V_{GS} = 4.5\text{V}$ , $I_D = 120\text{mA}$
$\Delta R_{DS(ON)}$	Change in $R_{DS(ON)}$ with Temperature			1.1	%/°C	$V_{GS} = 4.5\text{V}$ , $I_D = 120\text{mA}$
$G_{FS}$	Forward Transconductance		250		$\text{m}\Omega$	$V_{DS} = 25\text{V}$ , $I_D = 100\text{mA}$
$C_{ISS}$	Input Capacitance			50	pF	$V_{GS} = 0\text{V}$ , $V_{DS} = 25\text{V}$ , $f = 1\text{MHz}$
$C_{OSS}$	Common Source Output Capacitance			15		
$C_{RSS}$	Reverse Transfer Capacitance			5		
$t_{d(ON)}$	Turn-ON Delay Time			10	ns	$V_{DD} = 25\text{V}$ , $I_D = 120\text{mA}$ $R_{GEN} = 25\Omega$
$t_r$	Rise Time			7		
$t_{d(OFF)}$	Turn-OFF Delay Time			12		
$t_f$	Fall Time			15		
$V_{SD}$	Diode Forward Voltage Drop			1.8	V	$I_{SD} = 120\text{mA}$ , $V_{GS} = 0\text{V}$
$t_{rr}$	Reverse Recovery Time		400		ns	$I_{SD} = 120\text{mA}$ , $V_{GS} = 0\text{V}$

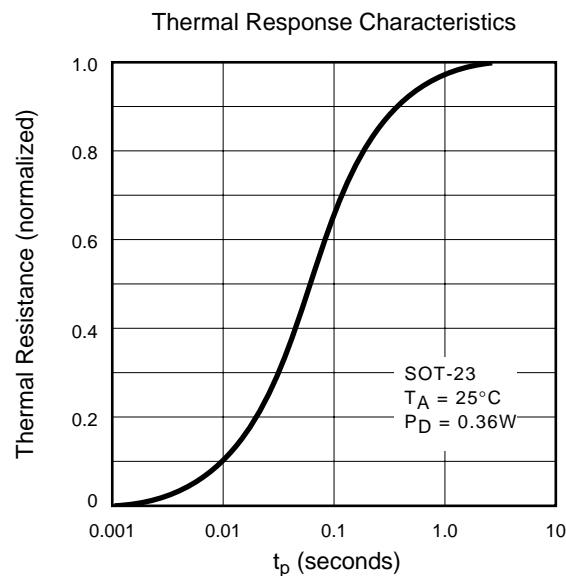
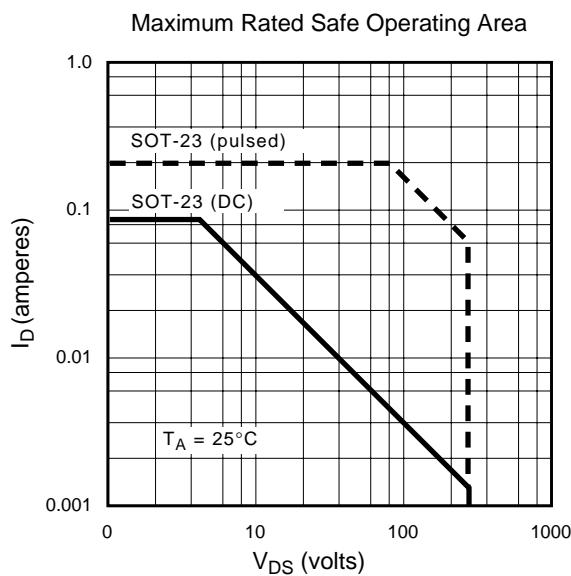
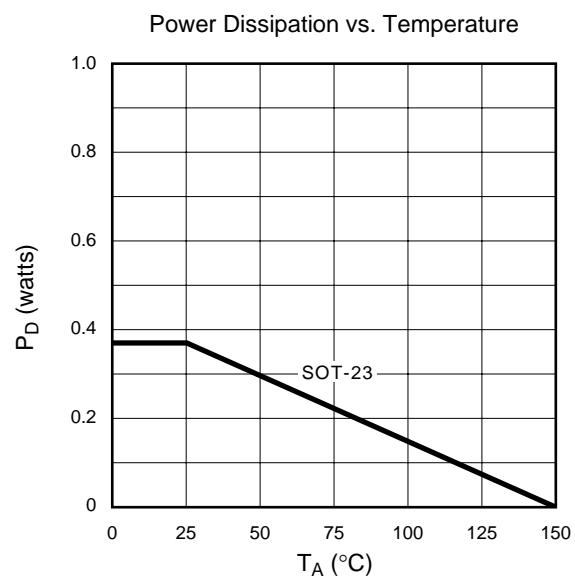
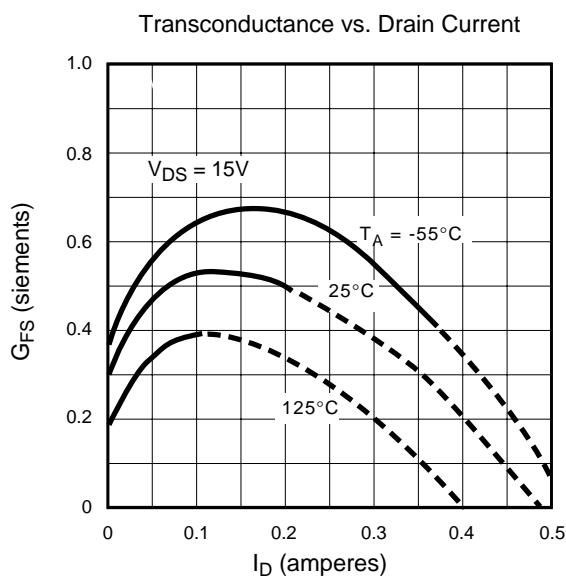
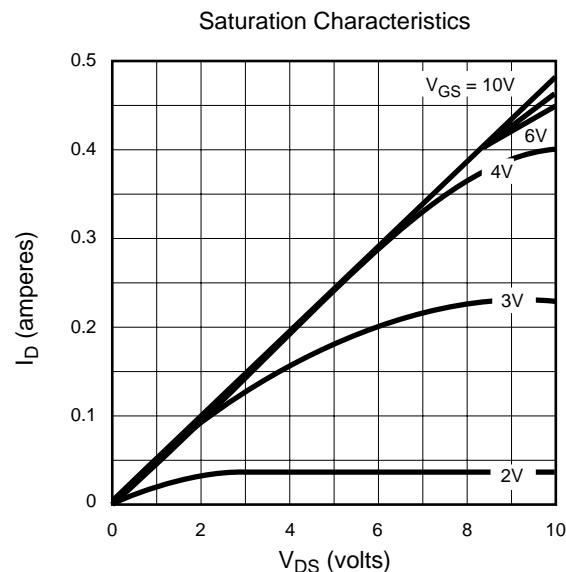
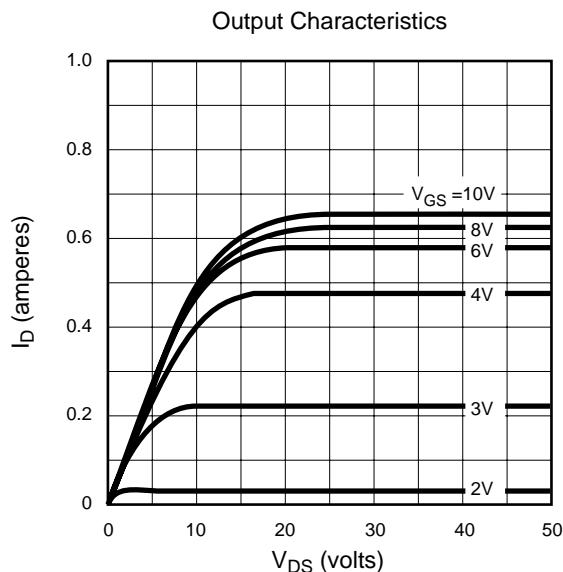
### Notes:

- All D.C. parameters 100% tested at 25°C unless otherwise stated. (Pulse test: 300μs pulse, 2% duty cycle.)
- All A.C. parameters sample tested.

## Switching Waveforms and Test Circuit



# Typical Performance Curves



# Typical Performance Curves

